

Search Notes

Application/Control No.

10/058,382

Examiner

Thien D. Tran

Applicant(s)/Patent under
Reexamination

HIGUCHI ET AL.

Art Unit

2616

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (USPGPUB, USPAT, USOCR, EPO, DERWENT) 370/201, 203, 208, 209	7/31/2006	TT